

NTMKE4890N

Power MOSFET 30 V, 155 A, Single N-Channel, ICEPAK

Features

- Low Package Inductance
- Low $R_{DS(on)}$ to Minimize Conduction Losses
- Low Capacitance to Minimize Driver Losses
- Optimized Gate Charge to Minimize Switching Losses
- Dual Sided Cooling Capability
- Compatible with MX Footprint and Outline
- These are Pb-Free Devices

Applications

- CPU Power Delivery
- DC-DC Converters
- Optimized for both Synch FET

MAXIMUM RATINGS ($T_J = 25^\circ\text{C}$ unless otherwise stated)

Parameter	Symbol	Value	Unit
Drain-to-Source Voltage	V_{DSS}	30	V
Gate-to-Source Voltage	V_{GS}	± 20	V
Continuous Drain Current $R_{\theta JA}$ (Note 1)	I_D	$T_A = 25^\circ\text{C}$	32
		$T_A = 70^\circ\text{C}$	25.5
Power Dissipation $R_{\theta JA}$ (Note 1)	P_D	$T_A = 25^\circ\text{C}$	2.8
			W
Continuous Drain Current $R_{\theta J-PCB}$ (Note 2)	I_D	$T_A = 25^\circ\text{C}$	155
		$T_A = 70^\circ\text{C}$	86
Power Dissipation $R_{\theta J-PCB}$ (Note 2)	P_D	$T_A = 25^\circ\text{C}$	65
			W
Continuous Drain Current $R_{\theta JC}$ (Note 1)	I_D	$T_C = 25^\circ\text{C}$	192
		$T_C = 70^\circ\text{C}$	154
Power Dissipation $R_{\theta JC}$ (Note 1)	P_D	$T_C = 25^\circ\text{C}$	100
			W
Pulsed Drain Current	$T_A = 25^\circ\text{C}, t_p = 10 \mu\text{s}$	I_{DM}	244
Current Limited by Package	$T_A = 25^\circ\text{C}$	I_{Dmax}	50
Operating Junction and Storage Temperature	T_J, T_{stg}		-40 to 150
			$^\circ\text{C}$
Source Current (Body Diode) (Note 1)	I_S	128	A
Drain to Source DV/DT	dV/dt	6.0	V/ns
Single Pulse Drain-to-Source Avalanche Energy ($T_J = 25^\circ\text{C}, V_{DD} = 30 \text{ V}, V_{GS} = 10 \text{ V}, I_L = 58 \text{ A}_{pk}, L = 0.3 \text{ mH}, R_G = 25 \Omega$)	E_{AS}	505	mJ
Lead Temperature for Soldering Purposes (1/8" from case for 10 s)	T_L	270	$^\circ\text{C}$

Stresses exceeding Maximum Ratings may damage the device. Maximum Ratings are stress ratings only. Functional operation above the Recommended Operating Conditions is not implied. Extended exposure to stresses above the Recommended Operating Conditions may affect device reliability.

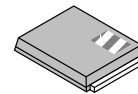
1. Surfaced mounted on FR4 board using 1 sq-in pad, 1 oz Cu.
2. Measured with a T_J of approximately 90°C using 1 oz Cu board.
3. Surfaced mounted on FR4 board using 1 sq-in pad, 2 oz Cu.



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$V_{(BR)DSS}$	$R_{DS(ON)} \text{ MAX}$	$I_D \text{ MAX}$
30 V	1.8 m Ω @ 10 V	155 A
	2.5 m Ω @ 4.5 V	

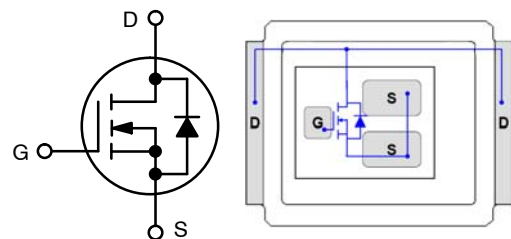


ICEPAK
E PAD
CASE 145AB

MARKING DIAGRAM



E4890 = Specific Device Code
 A = Assembly Location
 Y = Year
 WW = Work Week
 ■ = Pb-Free Package
 (Note: Microdot may be in either location)



N-CHANNEL MOSFET

ORDERING INFORMATION

Device	Package	Shipping†
NTMKE4890NT1G	ICEPAK (Pb-Free)	1500/Tape & Reel
NTMKE4890NT3G	ICEPAK (Pb-Free)	5000/Tape & Reel

†For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specification Brochure, BRD8011/D.

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THERMAL RESISTANCE MAXIMUM RATINGS

Parameter	Symbol	Value	Unit
Junction-to-Case (Drain) (Note 1)	$R_{\theta JC}$	1.25	°C/W
Junction-to-Ambient – Steady State (Note 1)	$R_{\theta JA}$	45	
Junction-to-Ambient – Steady State (Notes 2 and 3)	$R_{\theta JA}$	25	
Junction-to-PCB (Note 2)	$R_{\theta J-PCB}$	1.0	

ELECTRICAL CHARACTERISTICS ($T_J = 25^\circ\text{C}$ unless otherwise specified)

Parameter	Symbol	Test Condition	Min	Typ	Max	Unit
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OFF CHARACTERISTICS

Drain-to-Source Breakdown Voltage	$V_{(BR)DSS}$	$V_{GS} = 0\text{ V}, I_D = 250\ \mu\text{A}$	30			V
Drain-to-Source Breakdown Voltage Temperature Coefficient	$V_{(BR)DSS}/T_J$			20		mV/°C
Zero Gate Voltage Drain Current	I_{DSS}	$V_{GS} = 0\text{ V}, V_{DS} = 24\text{ V}$	$T_J = 25^\circ\text{C}$		1.0	μA
			$T_J = 125^\circ\text{C}$		100	
Gate-to-Source Leakage Current	I_{GSS}	$V_{DS} = 0\text{ V}, V_{GS} = \pm 20\text{ V}$			± 100	nA

ON CHARACTERISTICS (Note 4)

Gate Threshold Voltage	$V_{GS(TH)}$	$V_{GS} = V_{DS}, I_D = 250\ \mu\text{A}$	1.4		2.4	V
Negative Threshold Temperature Coefficient	$V_{GS(TH)}/T_J$			5.9		mV/°C
Drain-to-Source On Resistance	$R_{DS(on)}$	$V_{GS} = 10\text{ V}, I_D = 30\text{ A}$		1.5	1.8	m Ω
		$V_{GS} = 4.5\text{ V}, I_D = 30\text{ A}$		2.1	2.5	
Forward Transconductance	g_{FS}	$V_{DS} = 15\text{ V}, I_D = 25\text{ A}$		120		S

CHARGES, CAPACITANCES AND GATE RESISTANCE

Input Capacitance	C_{iss}	$V_{GS} = 0\text{ V}, f = 1.0\text{ MHz}, V_{DS} = 15\text{ V}$		7100		pF
Output Capacitance	C_{oss}			1360		
Reverse Transfer Capacitance	C_{rss}			690		
Total Gate Charge	$Q_{G(TOT)}$	$V_{GS} = 4.5\text{ V}, V_{DS} = 15\text{ V}, I_D = 25\text{ A}$		51.7		nC
Threshold Gate Charge	$Q_{G(TH)}$			6.0		
Gate-to-Source Charge	Q_{GS}			18.8		
Gate-to-Drain Charge	Q_{GD}			18.6		
Total Gate Charge	$Q_{G(TOT)}$	$V_{GS} = 10\text{ V}, V_{DS} = 15\text{ V}, I_D = 25\text{ A}$		104		nC

SWITCHING CHARACTERISTICS (Note 5)

Turn-On Delay Time	$t_{d(on)}$	$V_{GS} = 4.5\text{ V}, V_{DS} = 15\text{ V}, I_D = 25\text{ A}, R_G = 2.0\ \Omega$		25		ns
Rise Time	t_r			23		
Turn-Off Delay Time	$t_{d(off)}$			42		
Fall Time	t_f			12		

DRAIN-SOURCE DIODE CHARACTERISTICS

Forward Diode Voltage	V_{SD}	$V_{GS} = 0\text{ V}, I_S = 20\text{ A}$	$T_J = 25^\circ\text{C}$	0.78	1.0	V
			$T_J = 125^\circ\text{C}$	0.68		
Reverse Recovery Time	t_{RR}	$V_{GS} = 0\text{ V}, dI_S/dt = 200\text{ A}/\mu\text{s}, I_S = 20\text{ A}$		41.8		ns
Charge Time	t_a			19.4		
Discharge Time	t_b			22.4		
Reverse Recovery Charge	Q_{RR}			61		

PACKAGE PARASITIC VALUES

Gate Resistance	R_G	$T_A = 25^\circ\text{C}$		0.6	1.5	Ω
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4. Pulse Test: pulse width = 300 μs , duty cycle $\leq 2\%$.

5. Switching characteristics are independent of operating junction temperatures.

TYPICAL CHARACTERISTICS

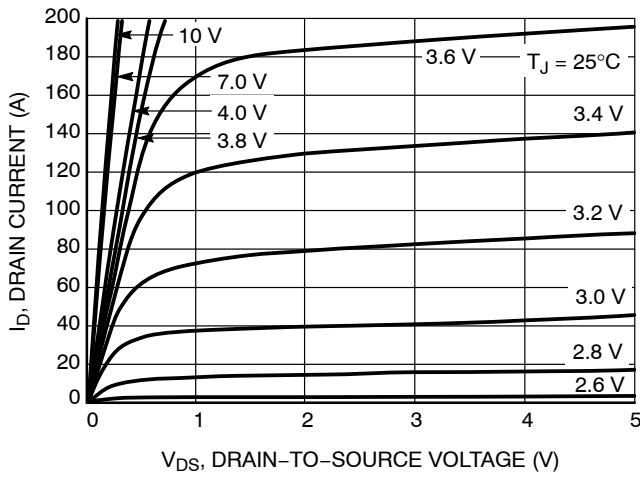


Figure 1. On-Region Characteristics

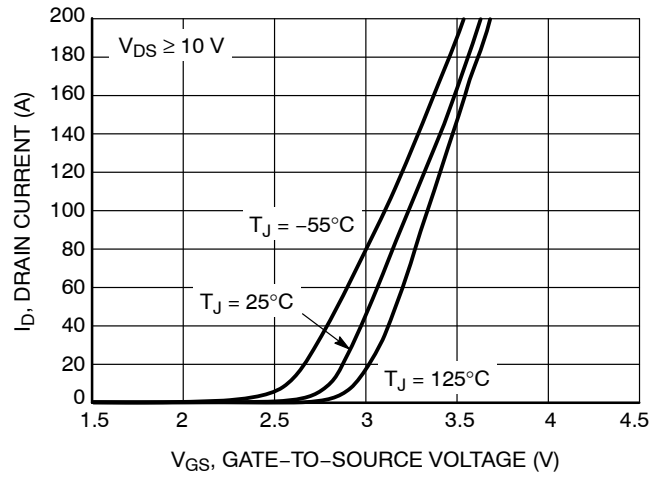


Figure 2. Transfer Characteristics

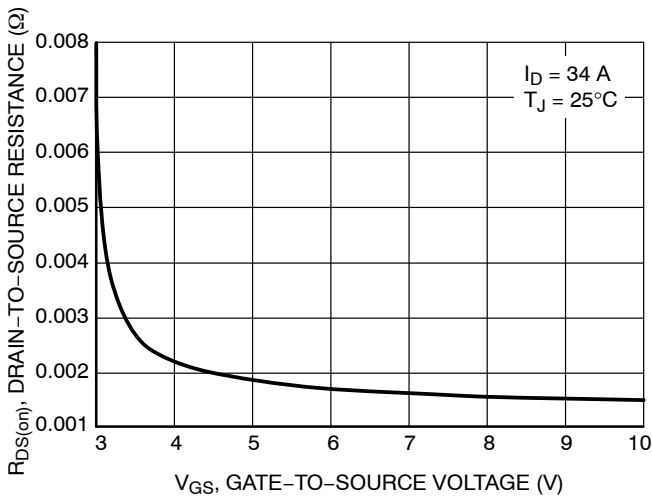


Figure 3. On-Resistance vs. Gate-to-Source Voltage

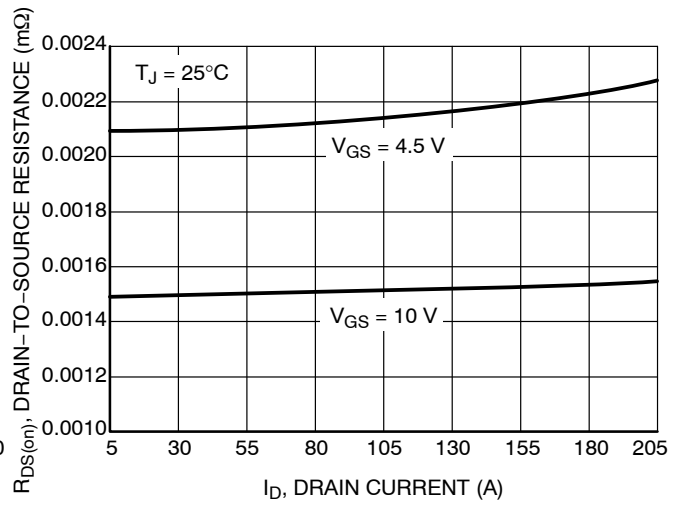


Figure 4. On-Resistance vs. Drain Current and Gate Voltage

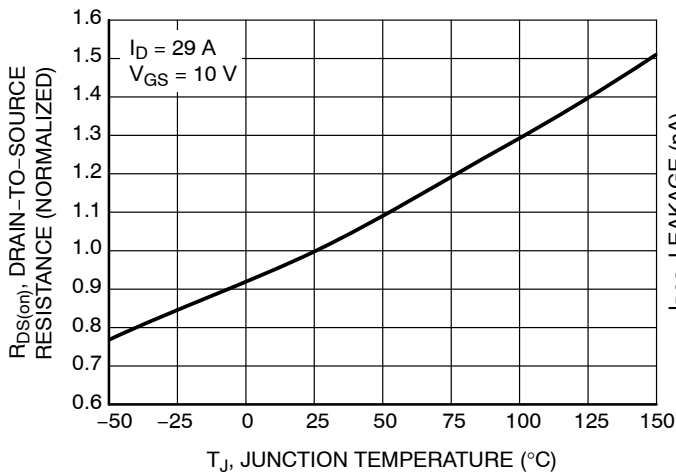


Figure 5. On-Resistance Variation with Temperature

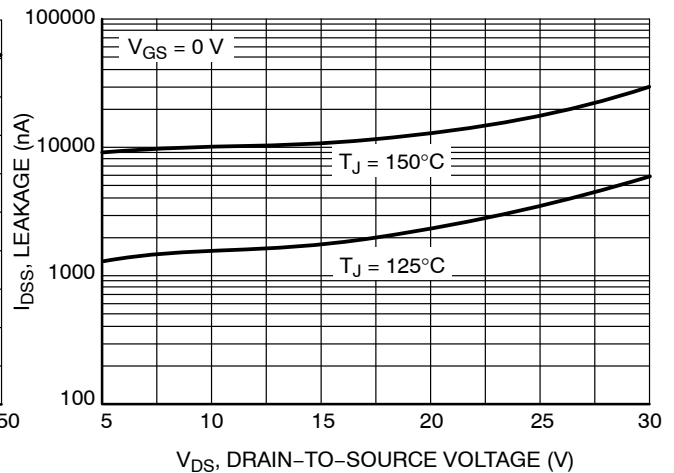


Figure 6. Drain-to-Source Leakage Current vs. Voltage

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TYPICAL CHARACTERISTICS

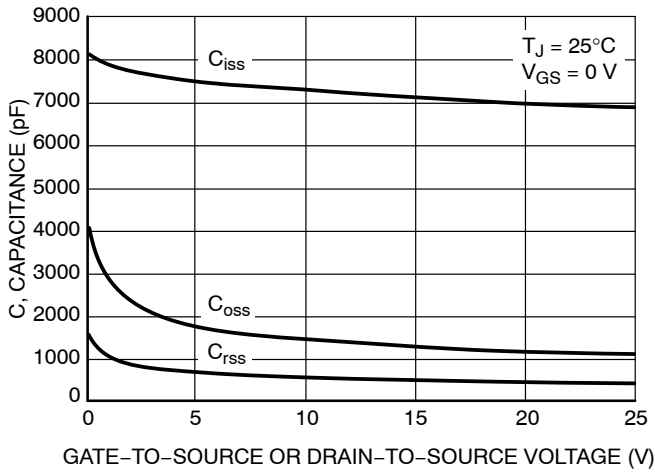


Figure 7. Capacitance Variation

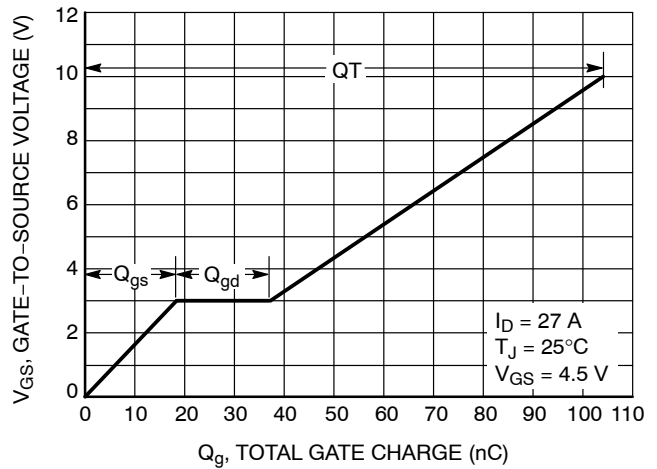


Figure 8. Gate-to-Source and Drain-to-Source Voltage vs. Total Charge

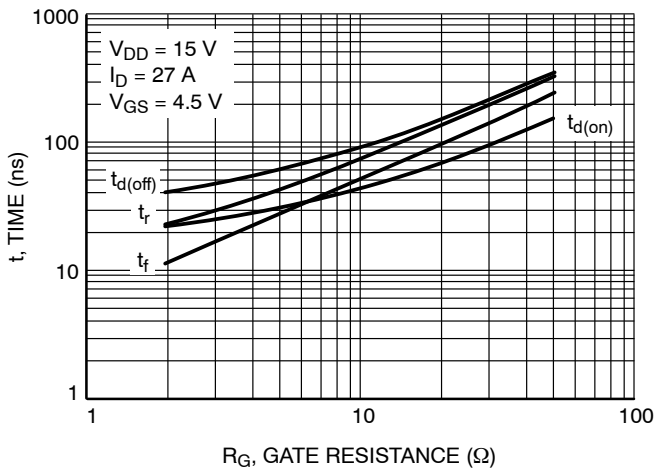


Figure 9. Resistive Switching Time Variation vs. Gate Resistance

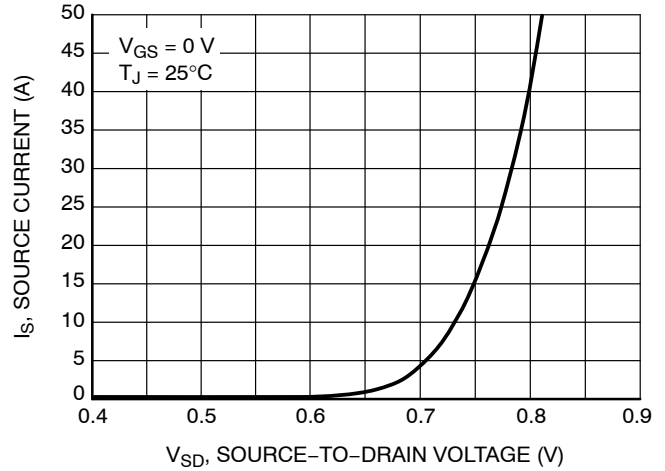


Figure 10. Diode Forward Voltage vs. Current

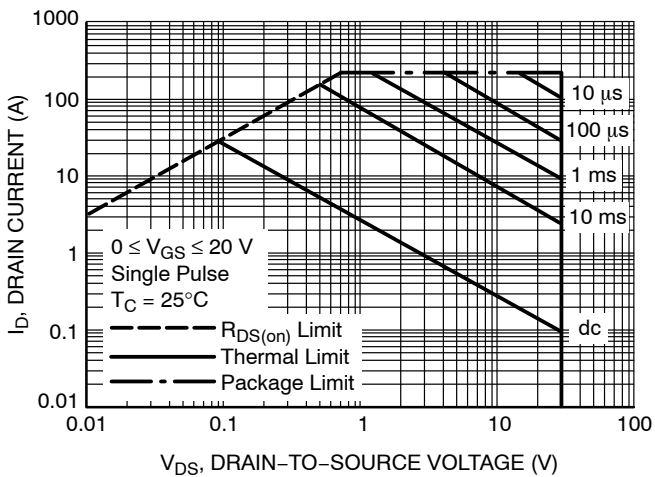


Figure 11. Maximum Rated Forward Biased Safe Operating Area

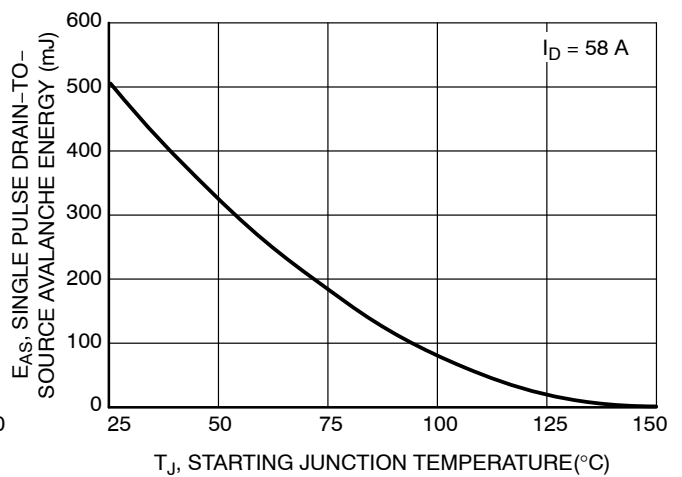


Figure 12. Maximum Avalanche Energy vs. Starting Junction Temperature

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TYPICAL CHARACTERISTICS

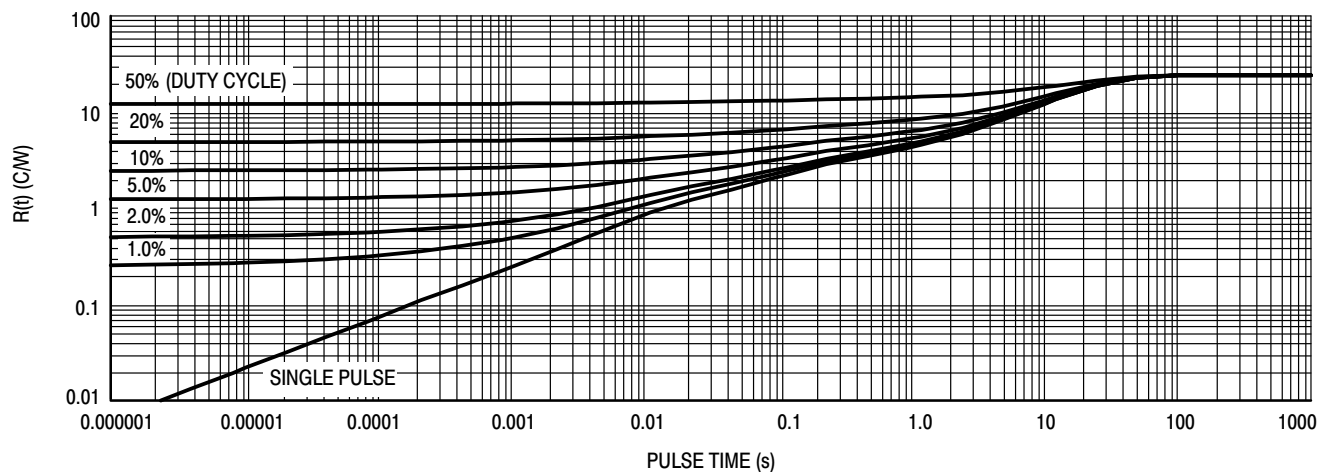
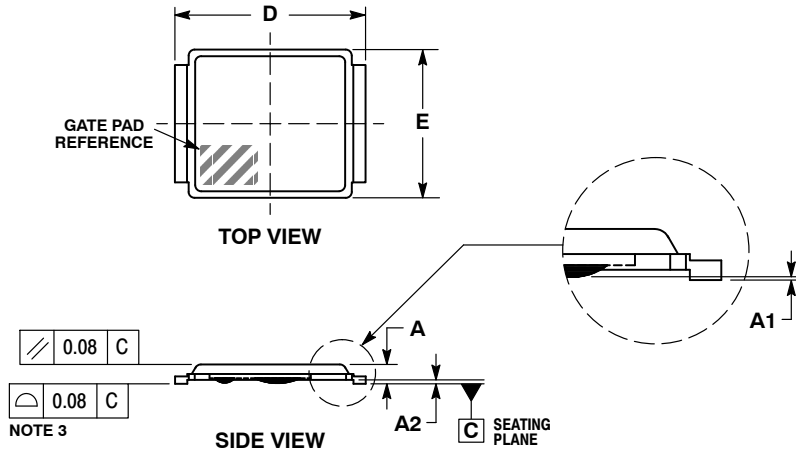


Figure 13. Thermal Impedance

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PACKAGE DIMENSIONS

ICEPAK 6.3x4.9 – E PAD
CASE 145AB-01
ISSUE 0

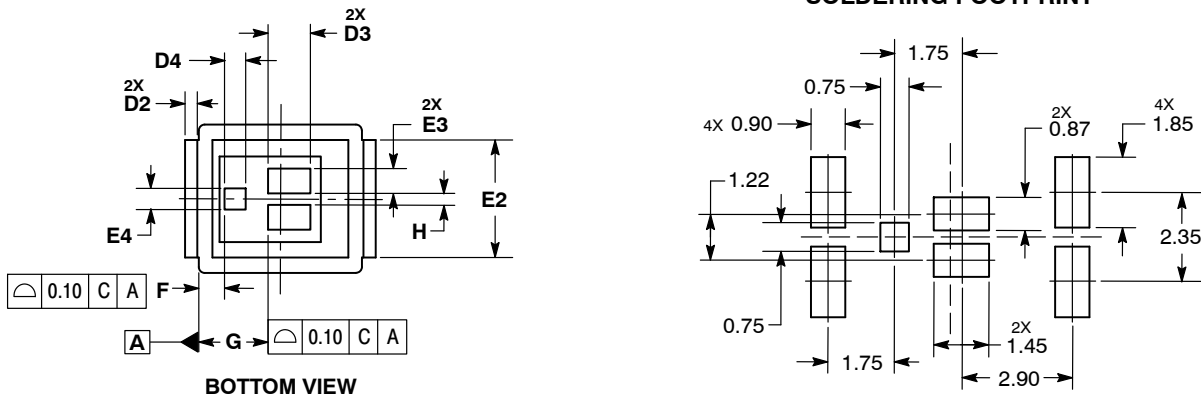


NOTES:

1. DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 1994.
2. CONTROLLING DIMENSION: MILLIMETERS.
3. COPLANARITY APPLIES TO THE FLANGES OF LEADFRAME ONLY.

DIM	MILLIMETERS	
	MIN	MAX
A	0.61	0.68
A1	0.02	0.08
A2	0.08	0.17
D	6.25	6.35
D2	0.35	0.45
D3	1.38	1.42
D4	0.68	0.72
E	4.80	5.05
E2	3.85	3.95
E3	0.80	0.84
E4	0.68	0.72
F	0.94 BSC	
G	2.54 BSC	
H	0.38	0.42

SOLDERING FOOTPRINT*



DIMENSIONS: MILLIMETERS

*For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

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